## References

- M. Fazio, S. L. Rota, Metrology on stamps, Phys. Educ., vol. 30, 1995, pp. 289–297.
  - DOI: http://dx.doi.org/10.1088/0031-9120/30/5/007
- [2] S. Middelhoek, S. A. Audet, Silicon Sensors, Academic PressLondon, 1989, ISBN:0-12-495-051-5.
- [3] K. T. V. Grattan, Measurement: system of scales and units, Concise Encyclopedia of Measurement and Instrumentation, L. Finkelstein, K. T. V. Grattan (editors), Pergamon PressOxford, 1994, ISBN:0-08-036212-5, pp. 209 214.
- [4] M. J. Lighthill, Contribution to the theory of heat transfer through a laminar boundary layer, Proc. of Royal Society, PublisherLondon, 1950, vol. A202, no. 3, pp. 359–377.
- [5] —, Contribution to the theory of heat transfer through a laminar boundary layer, Proc. of Royal Society, London, 1950, vol. A202, no. 3, pp. 359– 377.
- [6] V. Pop, P. P. L. Regtien, H. J. Bergveld, P. H. L. Notten, J. H. G. Op het Veld, Uncertainty analysis in a real-time state-of-charge evaluation system for lithium-ion batteries, Proc. of 18th IMEKO World Congress, Rio de Janeiro, Brazil, 2006, pp. 164 – 166.
- [7] T. Bruns, D. Röske, P. P. L. Regtien, F. Alegria, Template for an imeko event paper, 2014. Online. [Accessed:] https://acta.imeko.org/index.php/acta-imeko/information/authors
- [8] A. C. Serra, L. V. Biesen, Imeko the instrumentation and measurement confederation, Proc. of the 12th IMEKO TC1 & TC7 Joint Symposium on Man, Science & Measurement, Annecy, France, June, 2008. Online. [Accessed:]

 $https://www.imeko.org/publications/tc7-2008/\\IMEKO-TC1-TC7-2008-IKL-001.pdf$